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With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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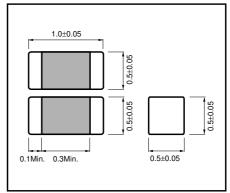
Multi-layer ceramic chip capacitors

MCH15 (1005 (0402) size, chip capacitor)

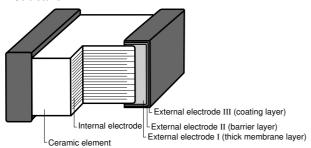
Features

- 1) Small size (1.0 x 0.5 x 0.5 mm) makes it perfect for lightweight portable devices.
- 2) Comes packed either in tape to enable automatic mounting or in bulk cases.
- 3) Precise uniformity of shape and dimensions facilitates highly efficient automatic mounting.
- 4) Barrier layer and end terminations to improve solderability.

●External dimensions (Units: mm)



Structure

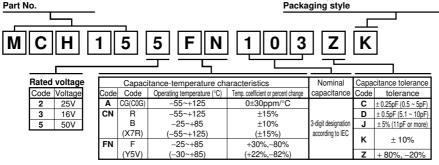


Product designation

| Code | Product thickness | Packaging specifications | Reel | Basic ordening unit (pcs.) |
|------|-------------------|-------------------------------------|----------------|----------------------------|
| K | 0.5mm | Paper tape (width 8 mm, pitch 2 mm) | φ180mm (7in.) | 10,000 |
| L | 0.5mm | Paper tape (width 8 mm, pitch 2 mm) | φ330mm (13in.) | 50,000 |
| С | 0.5mm | Bulk case | _ | 50,000 |

Reel (\(\phi\)180, \(\phi\)330mm): compatible with EIAJ ET-7200A Bulk case: compatible with EIAJ ET-7201A

Packaging style



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Capacitance range

For thermal compensation

| Part number MC | | | | | |
|--------------------|-----------------------------|-----------------|--|--|--|
| Capacitance (pF) | Temperature characteristics | A (CG) (C0G) | | | |
| Odpacitarice (pr.) | Rated voltage (V) Tolerance | 50V | | | |
| 0.5 0.75 1 | | | | | |
| 1.1 1.2 1.3 | | | | | |
| 1.5 1.6 1.8 | | | | | |
| 2 2.2 2.4 | C (± 0.25pF) | | | | |
| 2.7 3 3.3 | | | | | |
| 3.6 3.9 4 | | | | | |
| 4.3 4.7 5 | | | | | |
| 5.1 5.6 6 | | | | | |
| 6.2 6.8 7 | D (± 0.5pF) | | | | |
| 7.5 8 8.2 | | | | | |
| 9 9.1 10 | | | | | |
| 11 12 13 | | | | | |
| 15 16 18 | | | | | |
| 20 22 24 | J (± 5%) | | | | |
| 27 30 33 | | | | | |
| 36 39 43 | | | | | |

| Part n | MCH15 | |
|------------------|-----------------------------------|---------------|
| Capacitance (pF) | Temperature characteristics | (CG) (C0G) |
| Сараснансе (рг) | Rated voltage (V) Tolerance | 50V |
| 47 | | |
| 51 56 | | |
| 62 | | |
| 68 | | |
| 75 | | |
| 82 91 | | |
| 100 | | |
| 110 | | $\overline{}$ |
| 120 | | |
| 130 | J (± 5%) | |
| 150 160 | | |
| 180 | | |
| 200 | | |
| 220 | | |
| 240 | | |
| 270 300 | | |
| 330 | | |
| 360 | | |
| 390 | | |
| 430 470 | | |
| 510 | | |
| 560 | | |

Product thickness (mm) 0.5 ± 0.05

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High dielectric constant

| Part nu | MCH15 | | | | | |
|--------------------------|-----------------------------|------------------|------|--------------|-----------|-----|
| | Temperature characteristics | CN (R) (B) (X7R) | | FN (F) (Y5V) | | |
| Capacitance (pF) | Rated voltage (V) | 50V | 16V | 50V | 25V | 16V |
| | Tolerance | K(± | 10%) | Z | (+80, -20 | %) |
| 220 | | | | | | |
| 270 330 | | | | | | |
| 390 | | | | | | |
| 470 | | | | | | |
| 560 | | | | | | |
| 680 820 | | | | | | |
| 1,000 | | | | | | |
| 1,200 | | | | | | |
| 1,500 1,800 | | | | | | |
| 2,200 | | | | | | |
| 2,700 | | | | | | |
| 3,300 | | | | | | |
| 3,900 4,700 | | | | | | |
| 5,600 | | | | | | |
| 6,800 | | | | | | |
| 8,200 10,000 (0.01μF) | | | | | | |
| 12,000 | | | | | | |
| 15,000 | | | | | | |
| 18,000 | | | | | | |
| 22,000 27,000 | | | | | | |
| 33,000 | | | | | | |
| 39,000 | | | | | | |
| 47,000 56,000 | | | | | | |
| 68,000 | | | | | | |
| 82,000 | | | | | | |
| 100,000 (0.1μF) | | | | | | |
| 120,000 150,000 | | | | | | |
| 180,000 | | | | | | |
| 220,000 | | | | | | |
| 270,000 330,000 | | | | | | |
| 390,000 | | | | | | |
| 470,000 | | | | | | |
| 560,000 | | | | | | |

Product thickness (mm) 0.5 ± 0.05

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Characteristics

Class 1 (For thermal compensation)

| | Temperature characteristics | | | |
|--|-----------------------------|---|--|--|
| Item | | A (CG) (C0G) | Test methods/conditions (based on JIS C 5102) | |
| Operating temperature | | −55°C ~ 125°C | | |
| Nominal capacitance (C) | | Must be within the specified tolerance range. | Based on paragraph 7.8 and paragraph 9 Measured at room temperature and standard humidity, | |
| Dissipation factor (tanδ) | | 100/(400+20C)% or less: Less than 30 pF 0.1% or less : 30 pF or larger | $\begin{array}{lll} 1000 pF \ or \ less \ Measurement \ frequency : 1 \pm 0.1 MHz \\ Measurement \ voltage & : 1 \pm 0.1 Vrms. \\ \\ Over \ 1000 pF \ Measurement \ frequency : 1 \pm 0.1 kHz \\ Measurement \ voltage & : 1 \pm 0.1 Vrms. \\ \end{array}$ | |
| Insulation resistance (IR) | | 10,000M Ω or 500M $\Omega \cdot \mu F,$ whichever is smaller | Based on paragraph 7.6 Measurement is made after rated voltage is applied for 60 ± 5 | |
| Withstanding voltage | | The insulation must not be damaged. | Based on paragraph 7.1 Apply 300% of the rated voltage for 1 to 5s then measure. | |
| Temperature characteristics | | Within 0 ± 30ppm/°C | The temperature coefficients in table 12, paragraph 7.12 are calculated at 20°C and high temperature. | |
| Terminal adherence No detachment or signs of detachment. | | No detachment or signs of detachment. | Based on paragraph 8.11. 2. Apply 5N for 10 ± 1s in the direction indicated by the arrow. | |
| | Appearance | There must be no mechanical damage. | Chip is mounted to a board in the manner | |
| Resistance to vibration | Rate of capacitance change | Must be within initial tolerance. | shown on the right, subjected to vibration (type A in paragraph 8.2), and measured | |
| | Dissipation factor (tanδ) | Must satisfy initial specified value. | 24 ± 2 hrs. later. | |
| Solderability | | At least 3/4 of the surface of the two terminals must be covered with new solder. | Based on paragraph 8.13 Soldering temperature: 235 \pm 5°C Soldering time : 2 \pm 0.5s | |
| | Appearance | There must be no mechanical damage. | | |
| | Rate of capacitance change | \pm 2.5% or \pm 0.25 pF, whichever is larger. | Based on paragraph 8.14. | |
| Resistance to soldering | Dissipation factor (tanδ) | Must satisfy initial specified value. | Soldering temperature: 260 ± 5°C | |
| heat | Insulation resistance | $10,\!000M\Omega$ or $500M\Omega\cdot\mu F,$ whichever is smaller | Soldering time : 5 ± 0.5 s Preheating : $150 \pm 10^{\circ}$ C for 1 to 2 min. | |
| | Withstanding voltage | The insulation must not be damaged. | | |
| | Appearance | There must be no mechanical damage. | | |
| | Rate of capacitance change | \pm 2.5% or \pm 0.25 pF, whichever is larger. | Based on paragraph 9.3 | |
| Temperature cycling | Dissipation factor (tanδ) | Must satisfy initial specified value. | Number of cycles : 5 | |
| -,g | Insulation resistance | 10,000M Ω or 500M $\Omega \cdot \mu F$, whichever is smaller | Capacitance measured after 24 ± 2 hrs. | |
| | Appearance | There must be no mechanical damage. | Based on paragraph 9.9 | |
| Humidity load test | Rate of capacitance change | \pm 7.5% or \pm 0.75 pF, whichever is larger. | Test temperature: 40 ± 2°C | |
| | Dissipation factor (tanδ) | 0.5% or less | Relative humidity: 90% to 95% Applied voltage : rated voltage | |
| | Insulation resistance | 500M Ω or 25M $\Omega \cdot \mu F,$ whichever is smaller | Test time : 500 to 524 hrs. Capacitance measured after 24 ± 2 hrs. | |
| | Appearance | There must be no mechanical damage. | Based on paragraph 9.10 | |
| High- | Rate of capacitance change | \pm 3.0% or \pm 0.3 pF, whichever is larger. | Test temperature: Max. operating temp. | |
| temperature load test | Dissipation factor (tanδ) | 0.3% or less | Applied voltage : rated voltage × 200% Test time : 1,000 to 1,048 hrs. | |
| | Insulation resistance | 1,000M Ω or 50M $\Omega \cdot \mu$ F, whichever is smaller | Capacitance measured after 24 ± 2 hrs. | |

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Class 2 (High dielectric constant)

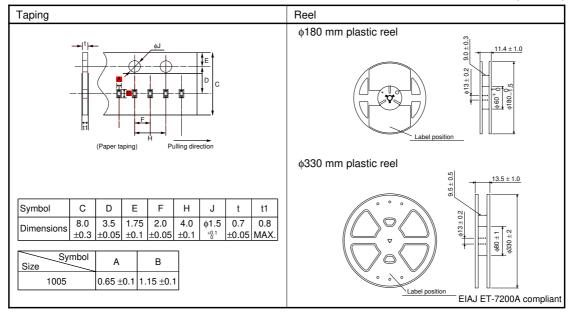
| Ciass 2 (High die | lectric constant) | | | | |
|-----------------------------------|----------------------------|---|--|---|--|
| Temperature characteristics | | CN (R) (B) (X7R) | FN (F) (Y5V) | Test methods/conditions (based on JIS C 5102) | |
| Operating temperature | | −55°C ~ +125°C | −30°C ~ +85°C | | |
| Nominal capacitance (C) | | Must be within the specified tolerance range. | | Based on paragraph 7.8 Measured at room temperature and standard humidity Measurement frequency: 1 \pm 0.1 kHz Measurement voltage :1.0 \pm 0.2 Vrms. | |
| Dissipation factor (tan8) | | 2.5% or less (when rated voltage is 16V: 3.5% or less) (when rated voltage is 16V: 7.5% or less) | | | |
| Insulation resistance (IR) | | 10,000M Ω or 500M Ω · μ F, whichever is smaller | | Based on paragraph 7.6 Measurement is made after rated voltage is applied for 60 ± 5s. | |
| Withstanding voltage | | The insulation must not be damaged. | | Based on paragraph 7.1 Apply 250% of the rated voltage for 1 to 5s then measure | |
| Temperature characteristics | | Within ± 15% | + 22, + 82% | The temperature coefficients in paragraph 7.12, table 8, condition B, are based on measurements carried out at 20°C, with no voltage applied. | |
| Terminal adherence | | No detachment or signs of detachment | | Based on paragraph 8. 11. 2. Apply 5N for 10 ± 1s in the direction indicated by the arrow. Pressure (5N) Capacitor Capacitor | |
| | Appearance | There must be no mechanical damage. | | Chip is mounted to a board in the manner shown on the right, subjected to vibration (type A in paragraph 8.2), | |
| Resistance to vibration | Rate of capacitance change | Must be within initial tolerance. | | | |
| | Dissipation factor (tanδ) | Must satisfy initial specified value. | | and measured 48 ± 4 hrs. later. Board | |
| Solderability | | At least 3/4 of the surface of the two terminals must be covered with new solder. | | Based on paragraph 8. 13 Soldering temperature : 235 \pm 5°C Soldering time : 2 \pm 0.5s | |
| | Appearance | There must be no mechanical damage. | | | |
| | Rate of capacitance change | Within ± 5.0% Within ± 20.0% | | Based on paragraph 8. 14. Soldering temperature: 260 ± 5°C Soldering time : 5 ± 0.5s Preheating : 150 ± 10°C for 1 to 2 min. | |
| Resistance to soldering | Dissipation factor (tanδ) | Must satisfy initial specified value. | | | |
| heat | Insulation resistance | 10,000M Ω or 500M Ω · μ F, whichever is smaller | | | |
| | Withstanding voltage | The insulation must not be damaged. | | | |
| | Appearance | There must be no mechanical damage. | | | |
| Temperature | Rate of capacitance change | Within ± 7.5% | Within ± 20.0% | Based on paragraph 9.3 Number of cycles : 5 | |
| cycling | Dissipation factor (tanδ) | Must satisfy initial specified value. | | Capacitance measured after 48 ± 4 hrs. | |
| | Insulation resistance | 10,000M Ω or 500M Ω · μF, whichever is smaller | | | |
| | Appearance | There must be no mechanical damage. | | Based on paragraph 9.9 | |
| İ | Rate of capacitance change | ± 12.5% or less | Within ± 30.0% | Test temperature: 40 ± 2°C | |
| Humidity load test | Dissipation factor (tanδ) | 5.0% or less | 7.5% or less (when rated voltage is 16V: 10.0%) | Relative humidity: 90% to 95% Applied voltage : rated voltage Test time : 500 to 524 hrs. | |
| | Insulation resistance | 500M Ω or 25M Ω · μF, whichever is smaller | | Capacitance measured after 48 \pm 4 | |
| | Appearance | There must be no mechanical damage. | | | |
| | Rate of capacitance change | Within ± 10.0% | Within ± 30.0% | Based on paragraph 9.10 | |
| High- temperature load test | Dissipation factor (tanδ) | 5.0% or less | 7.5% or less (when rated voltage is 16V: 10.0%) | Test temperature: Max. operating temp. Applied voltage : rated voltage × 200% Test time : 1,000 to 1,048 hrs. | |
| | Insulation resistance | 1,000MΩ or 50MΩ · μF, whichever is smaller | | Capacitance measured after 48 \pm 4 h | |

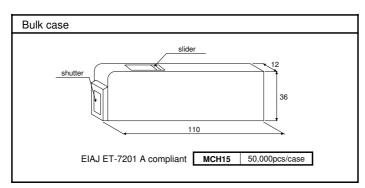
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Packaging specifications

(Units : mm)





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Electrical characteristics

■ A (C0G) Characteristics

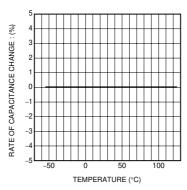


Fig.1 Capacitance-temperature characteristics

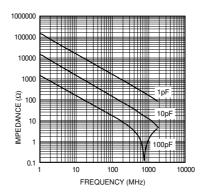


Fig.2 Impedance-frequency characteristics

■ CN (X7R) Characteristics

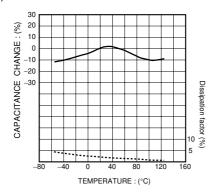


Fig.3 Capacitance-temperature characteristics

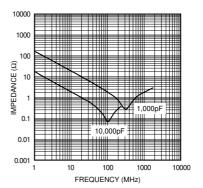


Fig.4 Impedance-frequency characteristics

■FN (Y5V) Characteristics

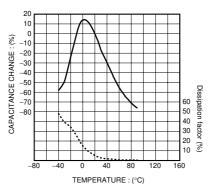


Fig.5 Capacitance-temperature characteristics

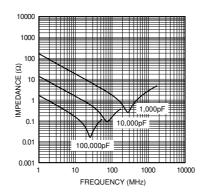
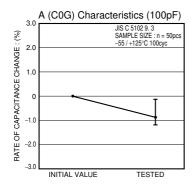


Fig.6 Impedance-frequency characteristics

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■ Temperature cycling test





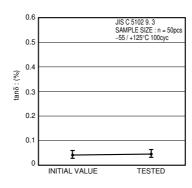


Fig.8 $tan\delta$

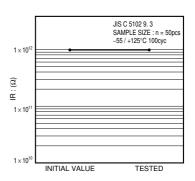


Fig.9 Insulation resistance

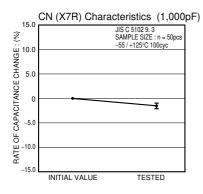


Fig.10 Rate of capacitance change

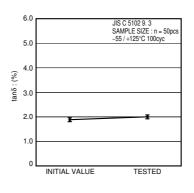


Fig.11 tanδ

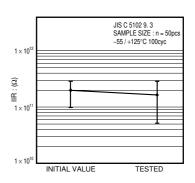


Fig.12 Insulation resistance

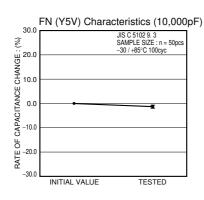


Fig.13 Rate of capacitance change

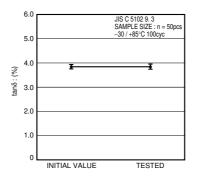


Fig.14 tanδ

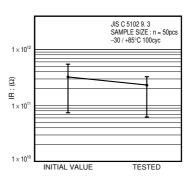
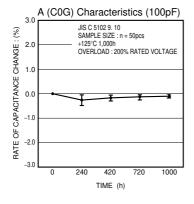


Fig.15 Insulation resistance

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■ High-temperature load test





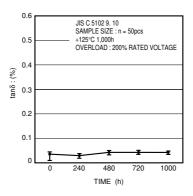


Fig.17 tanδ

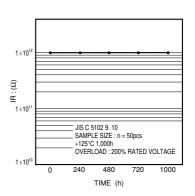


Fig.18 Insulation resistance

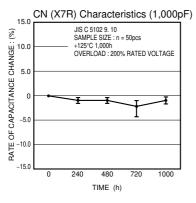


Fig.19 Rate of capacitance change

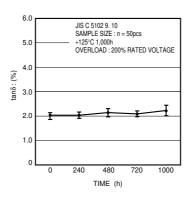


Fig.20 $tan\delta$

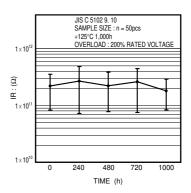


Fig.21 Insulation resistance

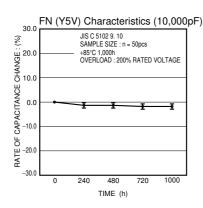


Fig.22 Rate of capacitance change

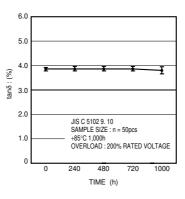


Fig.23 tanδ

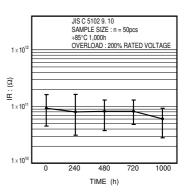
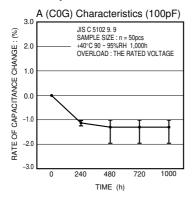
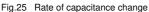


Fig.24 Insulation resistance

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■ Humidity load test





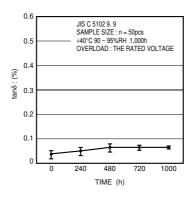


Fig.26 tanδ

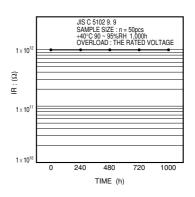


Fig.27 Insulation resistance

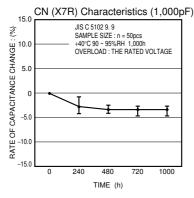


Fig.28 Rate of capacitance change

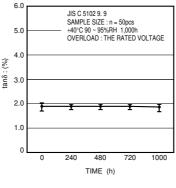


Fig.29 tanδ

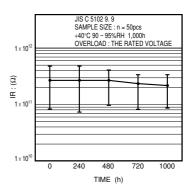


Fig.30 Insulation resistance

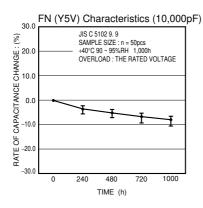


Fig.31 Rate of capacitance change

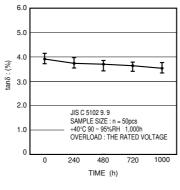


Fig.32 $tan\delta$

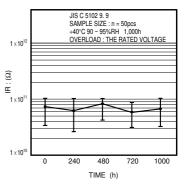


Fig.33 Insulation resistance

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